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b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
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Sheet 1 of 1

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LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTY DOCKET NO.

11299-003-999

APPLICATION NO

09/816,497

APPLICANT

Wilson Smart, et al.

FILING DATE

March 26, 2001

GROUP

1743

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A01	US 6,002,202	12-14-99	Meyer et al.			
	A02	US 5,728,089	03-17-98	Lal et al.			
	A03	US 4,468,282	08-28-84	Neukermans			
	A04						
	A05						
	A06						
	A07						
	A08						
	A09						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	B01							
	B02							
	B03							
	B04							
	B05							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	C01	Ciarlo, Dino R.; "Silicon Nitride Thin Windows for Biomedical Microdevices"; <i>Biomedical Microdevices</i> 4:1, pp. 63-68, 2002.
	C02	Goncz, K. K. et al.; "An environmental sample chamber for X-ray microscopy"; <i>Journal of Microscopy</i> , Vol. 168, Pt 1, October 1992, pp. 101-110.
	C03	

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.